



## Research Paper

**Cite this article:** Huang T-W, Huang Y-C, Chien C, Chiang K-C, Tsai J-H (2023). A 38-GHz demodulator with high image rejection in 65 nm-CMOS process. *International Journal of Microwave and Wireless Technologies* **15**, 1327–1333. <https://doi.org/10.1017/S1759078723000351>

Received: 19 September 2022  
Revised: 14 March 2023  
Accepted: 16 March 2023

**Keywords:**  
CMOS; Power amplifier

**Corresponding author:**  
Tian-Wei Huang, E-mail: [tihuang@ntu.edu.tw](mailto:tihuang@ntu.edu.tw)

<sup>1</sup>Graduate Institute of Communication Engineering, National Taiwan University, Taipei 10617, Taiwan; <sup>2</sup>Institute of Astronomy and Astrophysics, Academia Sinica, Taipei 10617, Taiwan and <sup>3</sup>Department of Electrical Engineering, National Taiwan Normal University, Taipei 10610, Taiwan

### Abstract

A high image rejection 38 GHz demodulator in TSMC 65-nm CMOS process is presented. To achieve better than  $-40$  dBc image rejection ratio (IRR), a low I/Q mismatch  $45^\circ$  LO power splitter of sub-harmonic mixer is proposed. In this design, the  $45^\circ$  LO power splitter is composed of a Wilkinson divider, a series delay line with electrical length of  $45^\circ$  on one side of the divider, and a shunt  $90^\circ$  transmission line on the other side. This configuration is attractive because of its design simplicity and easy fabrication. Compared with the conventional techniques that utilize capacitors and inductors instead of the shunt  $90^\circ$  transmission line, the proposed LO power splitter can alleviate the issue of process variation. The demodulator demonstrates an IRR lower than  $-40$  dBc from 37.5 to 41.5 GHz. In addition, conversion gain is  $1.3 \pm 0.9$  dB from 33 to 41 GHz with 6 dBm LO power. The total direct current power consumption is 78 mW from 1.0 V supply voltage. At the modulation scheme of 4096-QAM, the proposed demodulator demonstrates 1.7% ( $-35.1$  dB) error vector magnitude (EVM), which is very close to the EVM measurement floor 1.6% ( $-36$  dB) of our millimeter-wave signal analyzer.

### Introduction

For next-generation wireless systems, Wi-Fi 7 will use 4096-QAM in a 6-GHz frequency standard to increase the channel capacity and spectral efficiency. The IEEE 802.11be (Wi-Fi 7) standard draft sets a  $-38$  dB requirement on the transmitter error vector magnitude (EVM) for 4096-QAM [1]. The NHK (Nippon Housou Kyoukai) also proposed a required carrier to noise (C/N) ratio of around 31 dB for 4096-QAM 8k television transmission [2]. However, as the carrier frequency goes higher, the EVM measurement floor goes higher from  $-46$  dB at 5.95 GHz to  $-36$  dB at 26 GHz [3]. This paper will study the possibility of using 4096-QAM in a 38-GHz millimeter-wave (MMW) system that has a carrier frequency about 6–7 times higher than Wi-Fi 7.

With the Hartley architecture, in order to get good image rejection performance, the amplitudes of the I (in-phase)-path and the Q (quadrature)-path should be the same, and the phase difference between the I-path and the Q-path should be  $90^\circ$ . As a result, low I/Q mismatch is important when it comes to achieving good image rejection performance [4,5]. In addition, EVM can be affected by many factors, one of which being I/Q mismatch. I/Q mismatch can result in the constellation diagram being distorted [6]. The conventional configuration of the  $45^\circ$  LO power splitter in sub-harmonic mixer utilizes capacitors and inductors. However, it is sensitive to process variation, which is unavoidable in semiconductor manufacturing. The larger phase imbalance caused by process variation can lead to substantial degradation in the performance of the system.

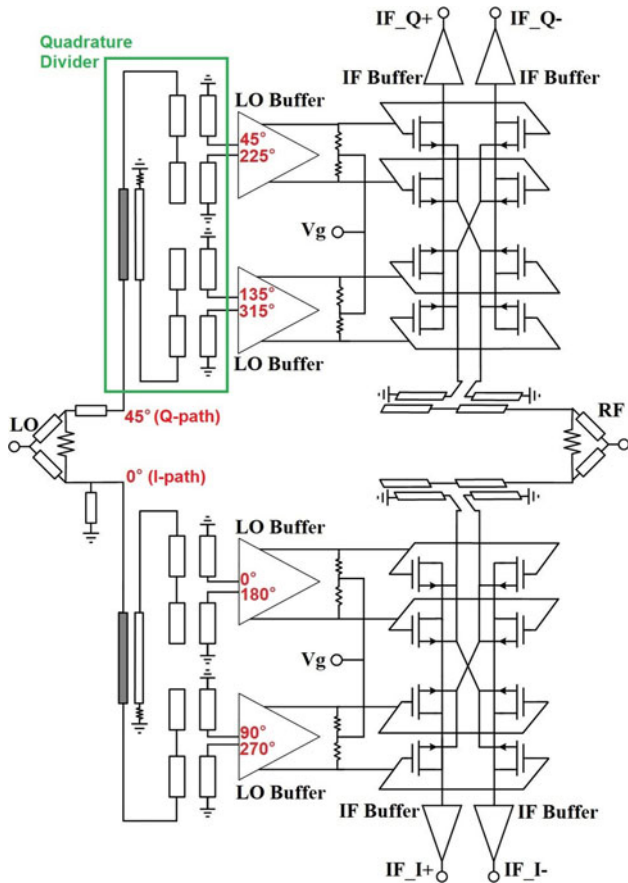
This paper proposes a transmission line based  $45^\circ$  LO power splitter, which replaces the capacitors and inductors with a shunt  $90^\circ$  transmission line at 19 GHz. This configuration is attractive not only because of its design simplicity and easy implementation, but also its ability to greatly reduce the effect of process variation.

### Circuit design

#### Sub-harmonic mixer

The schematic of the proposed demodulator is illustrated in Fig. 1. The LO signal is divided by a  $45^\circ$  LO power splitter into the I (in-phase)-path and the Q (quadrature)-path. On each of the I-path and the Q-path, a doubly balanced sub-harmonic mixer is utilized along with LO/IF buffers. This mixer configuration is a simplified version based on [5]. By simplifying the structure and omitting the usage of transistors at RF, there's no need for RF bias network. Only the

© The Author(s), 2023. Published by Cambridge University Press in association with the European Microwave Association. This is an Open Access article, distributed under the terms of the Creative Commons Attribution licence (<http://creativecommons.org/licenses/by/4.0/>), which permits unrestricted re-use, distribution and reproduction, provided the original article is properly cited.



**Fig. 1.** Schematic of the proposed demodulator, which is composed of a 45° LO power splitter, two quadrature dividers, two doubly balanced sub-harmonic mixers, LO/IF buffers and Marchand baluns at the RF port. Phase of LO signal is labeled using red numbers.

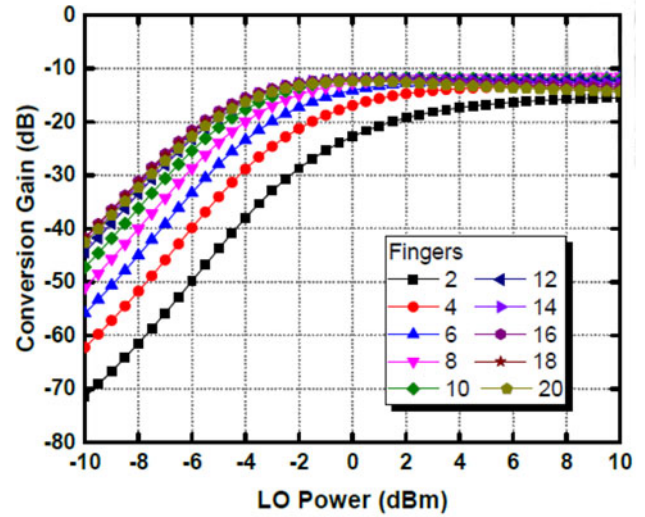
RF baluns and the power divider are needed at the RF port. By selecting the drain bias to be 0 V, bias network at the IF port can be simplified as well. This configuration has the benefit of high spur suppression [5].

When deciding the transistor size and gate bias condition of the mixer, transistor width of 2 μm (65-nm) and  $V_g$  of 0.2 V is chosen for an initial selection. Figure 2(a) plots the conversion gain (CG) under different fingers from 2 to 20 (the term “finger” means how many gates a transistor has). As can be observed, fingers from 14 to 20 have higher CG under the same LO power.

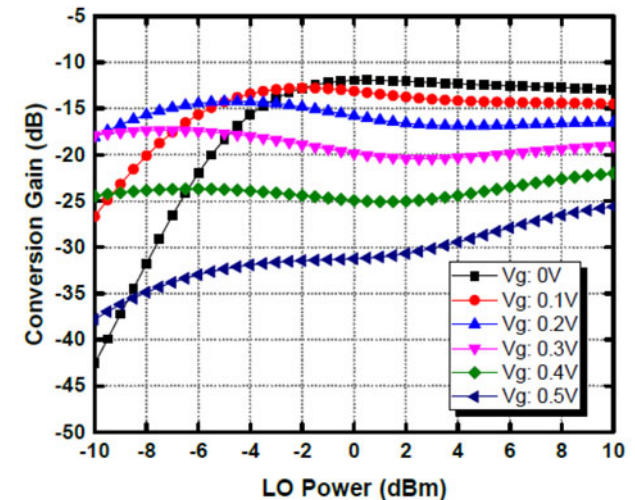
Therefore, we focus on the size of 2 μm × 14 fingers (width × fingers). Figure 2(b) plots the simulation results of CG versus LO power under different gate bias. It can be observed that the highest CG can be obtained with  $V_g = 0$  V over 0 to 10 dBm LO power. To get maximum CG, device size of 2 μm × 14 fingers and  $V_g = 0$  V are chosen.

**IF/LO buffer design**

Two stage inverter buffer amplifiers are added at the IF ports as IF buffer amplifiers to increase CG. The schematic of an IF buffer amplifier is shown in Fig. 3(a). VDD is set to 1.0 V to get maximum power and prevent transistors breakdown. For the first stage of the IF buffer amplifiers, the transistor sizes are 4 μm × 16 fingers (PMOS) and 4 μm × 10 fingers (NMOS). For the second stage of the IF buffer amplifiers, the transistor sizes are 4 μm × 30 fingers (PMOS) and 4 μm × 20 fingers

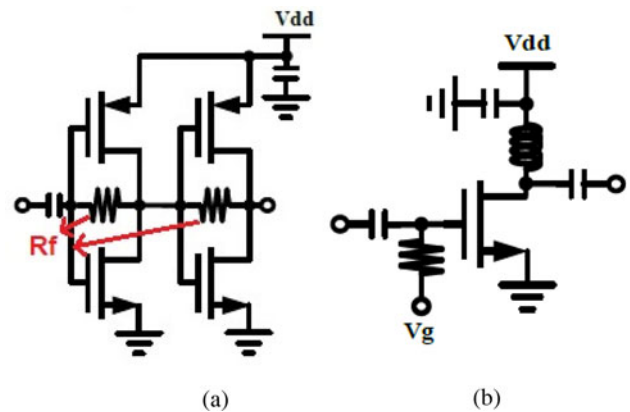


(a)



(b)

**Fig. 2.** Simulated conversion gain versus LO input power. (a) different finger number (transistor width of 2 μm and  $V_g = 0.2$  V is chosen for an initial selection); (b) different gate bias (transistor size of 2 μm × 14 fingers is decided).



**Fig. 3.** (a) Schematic of IF buffer amplifier; (b) Schematic of LO buffer amplifier.

(NMOS).  $R_f$  is 500 Ohms. The IF buffers can provide 20 dB gain with a 3-dB bandwidth of 5 GHz, and its power consumption is 37 mW.

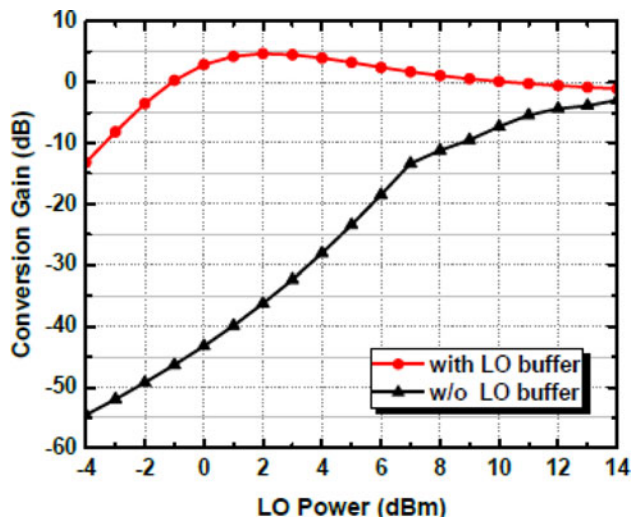


Fig. 4. Simulated conversion gain vs LO power with and without LO buffers.

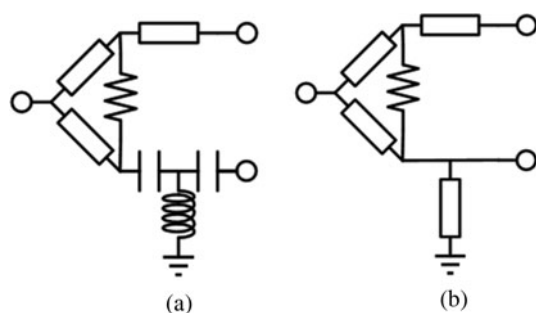


Fig. 5. 45° LO power splitter. (a) the conventional configuration, which utilizes two capacitors and one inductor; (b) proposed configuration, which replaces the capacitors and inductors with a 90° shunt transmission line at 19 GHz.

The proposed demodulator utilizes doubly balanced sub-harmonic mixers, each of which composes of 8 transistors. Because each of the I-path and the Q-path has a mixer, a total of 16 transistors are needed. Large LO power is needed to drive such a large number of transistors. To ease the burden of the

LO power requirement, common source amplifiers with high impedance load are used as LO buffers, which amplify the voltage swing to switch transistors easier. Figure 3(b) shows the schematic of a LO buffer amplifier. Gate bias ( $V_g$ ) is set to 0.6 V and device size of  $2\ \mu\text{m} \times 10$  fingers is chosen. As shown in Fig. 4, LO buffer can significantly lower the LO input power requirement, raising CG at 6 dBm LO power from -19 to 2.5 dB.

Passive components

Passive components play an important role in mixer design. When designing a sub-harmonic mixer, a passive component occupies a lot of chip area. To make the layout more compact, adjusting the size and shape of each component is necessary.

Amplitude imbalance and phase error can significantly affect the image rejection ratio (IRR) of a modulator/demodulator [4]. Hence at the LO port, it is important to design a four-way quadrature divider with minimum amplitude imbalance and low phase error. The LO signal is divided by a 45° LO power splitter into the I-path and the Q-path. On each of the I-path and Q-path, there is a four-way quadrature divider. A four-way quadrature divider is composed of two baluns and one 90° coupler. Because of sub-harmonic mixer architecture, the four-way quadrature divider is designed at a center frequency of 19 GHz. Its amplitude imbalance under 0.1 dB from 17 to 20 GHz.

At RF port, RF Marchand baluns are designed at a center frequency of 38 GHz.

45° LO power splitter

A mixer not only down-converts the desired signal but also the image signal. A 45° LO power splitter is used to separate the LO signal into the I-path and the Q-path, creating a 45° phase difference between the LO signals in these paths. The 45° phase difference becomes 90° phase difference when the sub-harmonic mixer mixes the 2LO signals with the RF signals to generate the IF signals, thus cancelling the image signal. Ideally, the phase difference between the output ports of the 45° power splitter should be 45°. The more the phase difference deviates from 45°, the higher the I/Q mismatch at the LO port, which dominates the

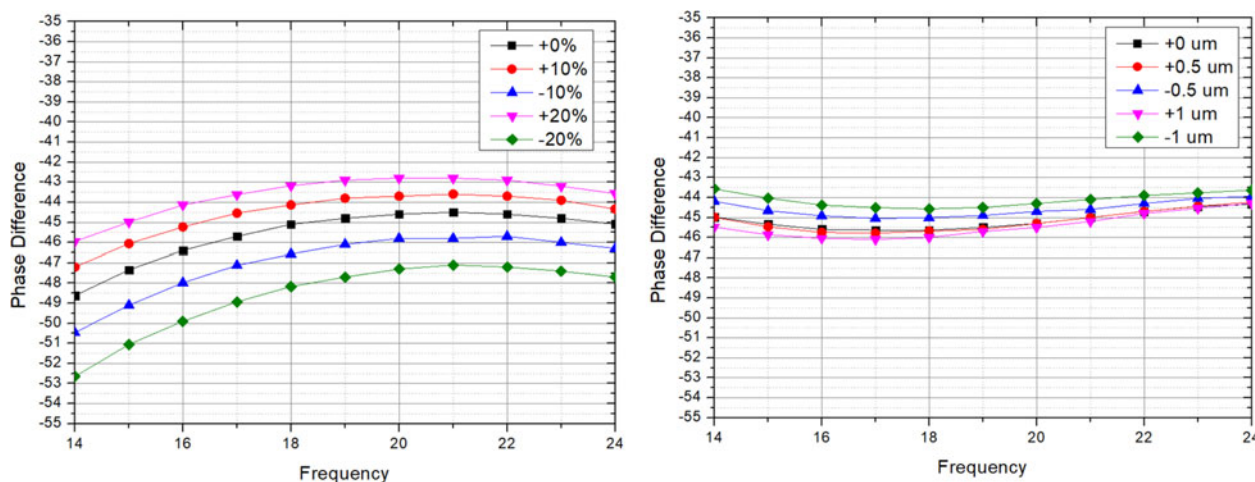
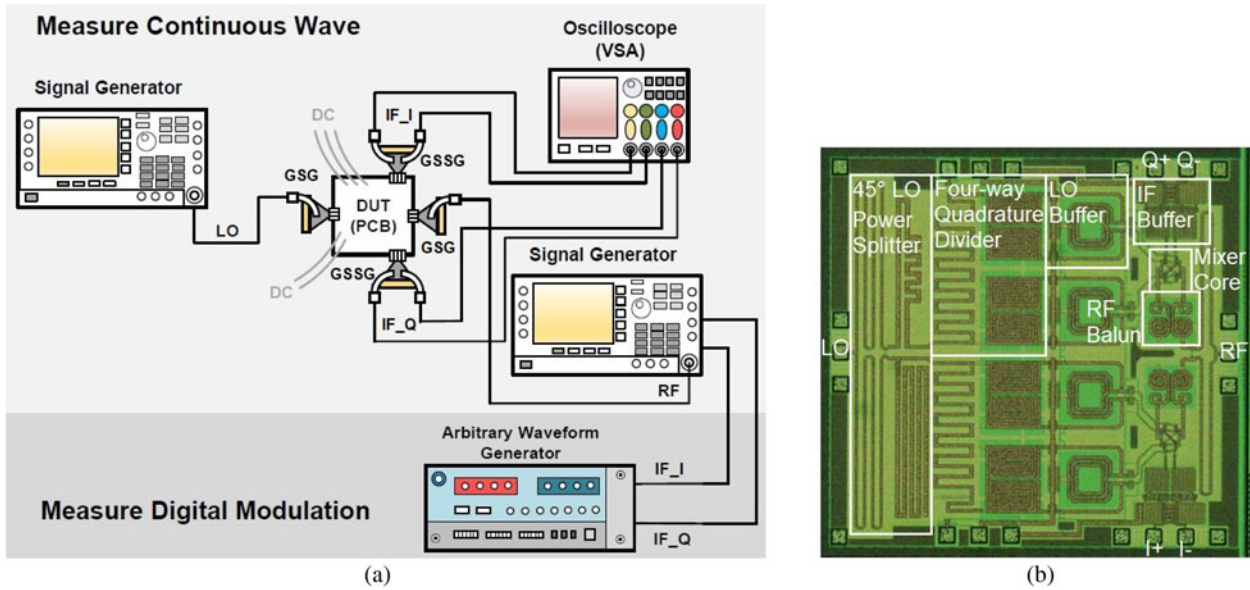
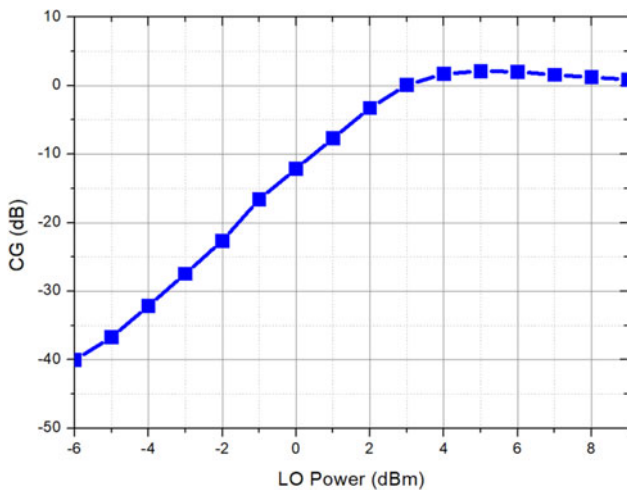


Fig. 6. Phase difference between the output ports of the 45° LO power splitter versus LO frequency. (a) When the capacitance value of the conventional configuration is affected by process variation; (b) When the width of the 90° shunt transmission line in the proposed configuration is affected by process variation.

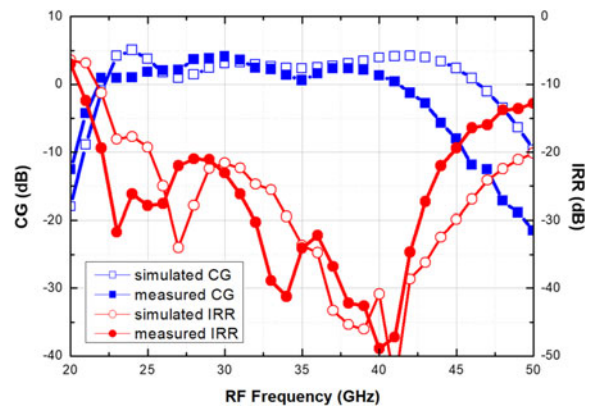




**Fig. 7.** (a) The measurement setup for the demodulator; (b) Chip photo of the proposed demodulator. The chip area is  $1.27 \times 1.2 \text{ mm}^2$ . The  $45^\circ$  LO power splitter, the four-way quadrature divider (which composes of a coupler and two baluns), the LO buffer, the IF buffer, the mixer core, and the RF balun are indicated.



**Fig. 8.** Measured CG vs LO power. The RF input power is set to be  $-10 \text{ dBm}$ . The conversion gain saturates at  $6 \text{ dBm}$  LO input power.



**Fig. 9.** Simulated and measured CG and IRR versus RF frequency. The image rejection ratio is lower than  $-30 \text{ dBc}$  from  $33$  to  $42.5 \text{ GHz}$ , and is lower than  $-40 \text{ dBc}$  from  $37.5$  to  $41.5 \text{ GHz}$ . Combining  $3 \text{ dB}$ -criterion with IRR performance, we define the measured RF bandwidth as  $33$  to  $41 \text{ GHz}$  for IRR better than  $-30 \text{ dB}$ . Measured CG is  $1.3 \pm 0.9 \text{ dB}$  within the RF bandwidth. The measurement results were obtained with LO input power of  $6 \text{ dBm}$  and RF input power of  $-10 \text{ dBm}$ .

IRR. As a result,  $45^\circ$  LO power splitter is a key component when designing modulators and demodulators [4–9].

The circuit configuration of the conventional  $45^\circ$  power splitter is shown in Fig. 5(a). It composes of a Wilkinson divider, a delay line with electrical length of  $45^\circ$ , two capacitors and one inductor. This configuration is more sensitive to process variation. That is, if the capacitance value deviates from the optimal value, the output phase difference is affected heavily. In order to realize a  $45^\circ$  power splitter less sensitive to process variation, the two capacitors and one inductor are replaced with a short stub with electrical length of  $90^\circ$  at  $19 \text{ GHz}$ , as shown in Fig. 5(b). According to the quarter-wavelength transmission line theory, the input impedance of the short stub is in theory infinite at the desired frequency.

Figure 6 compares the different configurations of  $45^\circ$  power splitter. It can be observed from Fig. 6(a) that a 10% variation

in capacitance can lead to more than  $1^\circ$  phase error; if the capacitance varies by 20%, phase error can go up to almost  $3^\circ$ . The proposed configuration is less affected by process variation, as shown in Fig. 6(b). When the width of the  $90^\circ$  shunt transmission line varies by  $0.5 \mu\text{m}$ , the phase error is  $0.5^\circ$  at most. Even if the width of the  $90^\circ$  shunt transmission line varies by  $1 \mu\text{m}$ , the phase error only goes up to approximately  $1^\circ$ . The comparison shows that the proposed transmission line based configuration of  $45^\circ$  LO power splitter is more reliable when it comes to dealing with process variation. When it comes to used chip area, the capacitor/inductor based  $45^\circ$  LO power splitter occupies approximately half of the area of the proposed one. However, the proposed transmission line based approach can be bent into a meander-like layout which fully utilizes chip area and can be adjusted according to nearby components.

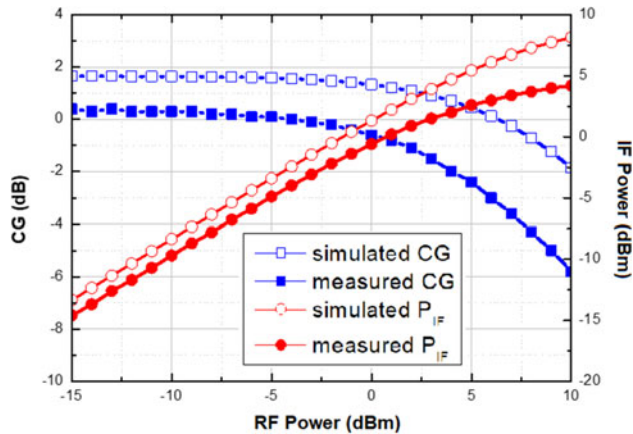


Fig. 10. Conversion gain (CG) and IF output power vs RF input power. The 1 dB compression point (IP1 dB) is at 0 dBm RF power.

Measurement results

The presented 38-GHz demodulator with high image rejection in TSMC 65-nm CMOS process is designed and fabricated. The chip photograph of this demodulator is shown in Fig. 7(b) with chip size of  $1.27 \times 1.2 \text{ mm}^2$  including all the testing pads. The direct current (DC) pads were wire-bonded to a standard FR-4 printed circuit board. The differential output signals were tested via on-wafer GSSG probes. The block diagram of the analog/digital signal measurement system is shown in Fig. 7(a). The LO source of the demodulator are fed by the signal generator (Keysight N5173B EXG X-Series). Then, the down-converted signal IF was received by oscilloscope (Keysight VSA) and converted time domain signal to frequency domain. The digital I/Q and OFDM signal sources are generated by an arbitrary waveform generator (AWG) (Keysight M8190A) with Signal Studio. In the digital demodulation measurement, the modulation signal will be up-converted to 38 GHz by a signal generator (Keysight

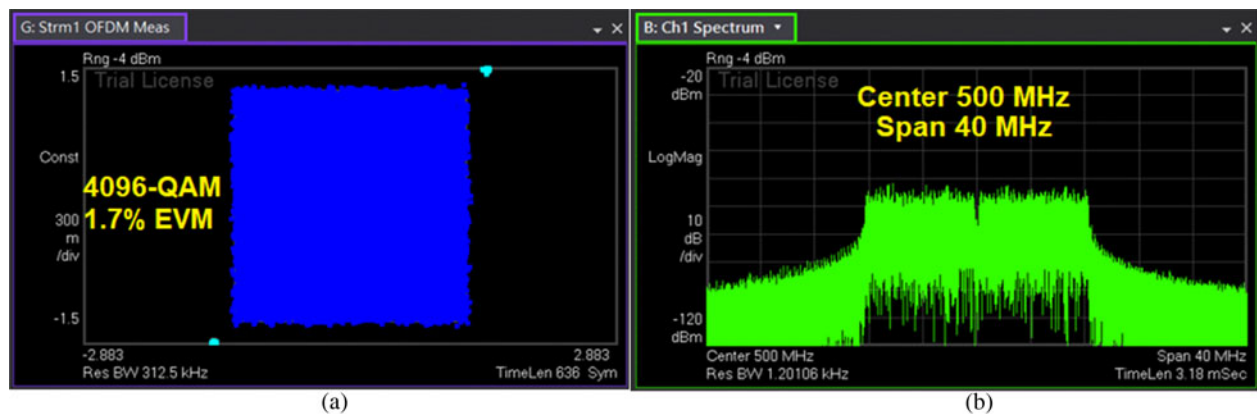


Fig. 11. The proposed demodulator demonstrates a measured EVM of 1.7% (−35 dB) at the modulation scheme of 4096-QAM. This result is close to the EVM measurement floor (1.6%/−36 dB) of millimeter-wave frequency band. The measurement results were obtained with LO input power of 6 dBm and RF input power of −10 dBm, which is 10 dB below the IP1 dB point. (a) Constellation diagram; (b) Output spectrum.

Table 1. Performance summary and comparison.

	[4] <sup>a</sup> TMTT-13	[5] TMTT-07	[6] TMTT-13	[11] JSSC-19	[12] MWCL-08	[13] EuMC-12	This work
Process	CMOS 65-nm	CMOS 0.13- $\mu\text{m}$	GaAs pHEMT 0.15- $\mu\text{m}$	CMOS 65-nm	GaInP-GaAs HBT	CMOS 0.18- $\mu\text{m}$	CMOS 65-nm
RF Frequency <sup>b</sup> (GHz)	64–84	35–65	51–68	35–38.75	20–40	25–52	33–41
CG	$0 \pm 1$	$-7.5 \pm 1.5$	$-14 \pm 2$	$26.5^c$	8	-16	$1.3 \pm 0.9$
IRR	<−40	N/A	<−40 @51–65 GHz	<−35	N/A	<−15	<−30 @33–42.5 GHz <−40 @37.5–41.5 GHz
EVM	<2% 256-QAM	N/A BPSK	<5% 64-QAM	N/A	N/A QPSK	N/A BPSK	1.7% 4096-QAM
Chip area ( $\text{mm}^2$ )	$1.05 \times 0.82$	$1 \times 1$	$3.2 \times 1.4$	0.46	$4 \times 3$	$0.6 \times 0.7$	$1.27 \times 1.2$
DC (mW)	40.8	90.8	420	52.5	981	0	78

<sup>a</sup>modulator.

<sup>b</sup>RF frequencies with the listed CG.

<sup>c</sup>LNA + IR down mixer + calibration circuitry.

E8257D). The Keysight VSA software (VSA 89601b) is used to further analyze the data and calculate the EVM.

### Continuous waveform (CW) measurement

Figure 8 depicts the measured CG versus LO power drive. The RF input power is set to be  $-10$  dBm. The measured results show that the CG will saturate at a LO power of 6 dBm.

The simulation and measurement results of CG and IRR versus RF frequency are plotted in Fig. 9. The LO frequencies are from 10 to 25 GHz and the IF frequency is 100 MHz. The LO input power is 6 dBm and the RF input power is  $-10$  dBm. It can be observed that the IRR is lower than  $-30$  dBc from 33 to 42.5 GHz, and is lower than  $-40$  dBc from 37.5 to 41.5 GHz. Combining 3 dB-criterion with IRR performance, we define the measured RF bandwidth as 33 to 41 GHz for IRR better than  $-30$  dBc. Measured CG is  $1.3 \pm 0.9$  dB within the RF bandwidth.

Figure 10 shows the simulation and measurement results of CG and IF output power ( $P_{IF}$ ) versus RF input power ( $P_{RF}$ ). The input 1 dB compression point (IP1 dB) is at 0 dBm RF input power.

### Modulation signal measurement

Constellation diagrams are useful to display the characteristics of signal impairments related to I and Q. The distortions of the constellation will degrade EVM and will also increase the bit-error rate [10]. To further characterize the demodulator, modulated signal measurements are performed based on the test setup in Fig. 7 (a). The OFDM signals are generated by an AWG and up-converted to high frequency, then fed to the RF input. The measured constellation diagrams and output spectrum are plotted in Fig. 11. At 38 GHz, the EVM of the proposed demodulator is 1.7% ( $-35$  dB) at the modulation scheme of 4096-QAM. The measured EVM is very close to the measurement floor 1.6% ( $-36$  dB) of our MMW signal analyzer [3].

### Conclusion

In this paper, a 38-GHz demodulator with high image rejection fabricated in TSMC 65-nm CMOS process is presented. Due to the sub-harmonic mixer architecture, a transmission line based  $45^\circ$  LO power splitter is adopted. When compared with conventional design techniques, this transmission line based power splitter is much less sensitive to process variation.

The demodulator performs good IRR lower than  $-40$  dBc from 37.5 to 41.5 GHz. In system applications, good IRR performance reduces the interference of image and improves signal quality. In addition, CG is within the range of  $1.3 \pm 0.9$  dB from 33 to 41 GHz with 6 dBm LO power. The total DC power consumption is 78 mW from 1.0 V supply voltage. This demodulator also demonstrates 1.7% ( $-35.1$  dB) EVM at the modulation scheme of 4096-QAM. Table 1 summarizes the performance of previous work. The high CG in [11] was obtained with a LNA. Compared to [12], although we have lower CG, the chip area of [12] is much larger, and the power consumption is very high. The CG, IRR performance and fractional bandwidth of [4] is similar to our work. However, EVM performance of our work (1.7% under 4096-QAM) is better than [4]. In addition, EVM performance similar to our work is not seen in the other works in Table 1. Overall, the proposed demodulator is featured with good CG, IRR and EVM performance.

**Acknowledgement.** This work was supported in part by the National Science and Technology Council (NSTC), Taipei, Taiwan, under Contract NSTC 111-2221-E-002-143-MY3, NSTC 111-2218-E-002-023, and NTU-CC-112L894703, SRC 2810.081

**Financial support.** The authors report no conflict of interest.

### References

1. Garcia-Rodriguez A, López-Pérez D, Galati-Giordano L and Geraci G (2021) IEEE 802.11be: Wi-Fi 7 strikes back. *IEEE Communications Magazine* 59, 102–108.
2. Large-capacity Transmission Technologies for Next-generation Terrestrial Broadcasting. <https://www.nhk.or.jp/str/english/publica/bt/52/3.html> (Accessed 5 August 2022).
3. N9030B PXA X-Series Signal Analyzer, Multi-touch. <https://www.keysight.com/tw/zh/assets/7018-05093/data-sheets/5992-1317.pdf> (Accessed 5 August 2022).
4. Lin WH, Yang HY, Tsai JH, Huang TW and Wang H (2013) 1024-QAM high image rejection E-band subharmonic IQ modulator and transmitter in 65-nm CMOS process. *IEEE Transactions on Microwave Theory and Techniques* 61, 3974–3985.
5. Tsai J-H and Huang T-W (2007) 35–65-GHz CMOS broadband modulator and demodulator with sub-harmonic pumping for MMW wireless gigabit applications. *Microwave Theory and Techniques, IEEE Transactions on* 55, 2075–2085.
6. Tsai Z-M, Liao H-C, Hsiao Y-H and Wang H (2013) V-band high data-rate I/Q modulator and demodulator with a power-locked loop LO source in 0.15- $\mu$ m GaAs pHEMT technology. *IEEE Transactions on Microwave Theory and Techniques* 61, 2670–2684.
7. Tsai Y-C, Kuo J-L, Tsai J-H, Lin K-Y and Wang H (2011) A 50–70 GHz I/Q modulator with improved sideband suppression using HPF/LPF based quadrature power splitter. *IEEE MTT-S International Microwave Symposium Digest*, June 2011, pp. 1–4.
8. Chou Y-T, Lin Y-H and Wang H (2016) A high image rejection E-band subharmonic IQ demodulator with low power consumption in 90-nm CMOS process. *European Microwave Integrated Circuits Conference*, October 2016, pp. 488–491.
9. Hayashi H, Okazaki H, Kanda A, Hirota T and Muraguchi M (1998) Millimeter-wave-band amplifier and mixer MMICs using a broad-band 45 degrees power divider/combiner. *IEEE Transactions on Microwave Theory and Techniques* 46, 811–819.
10. McKinley M, Remley KA, Myslinski M, Kenney JS, Schreurs D, Nauwelaers B (2004) EVM Calculation for Broadband Modulated Signals. *64th ARFTG Conf. Dig.*, December 2004, pp. 45–52.
11. Mondal S and Paramesh J (2019) A reconfigurable 28-/37-GHz MMSE-adaptive hybrid-beamforming receiver for carrier aggregation and multi-standard MIMO communication. *IEEE Journal of Solid-State Circuits* 54, 1391–1406.
12. Hamed KW, Freundorfer AP, Antar YMM, Frank P and Sawatzky D (2008) A high-bit rate Ka-band direct conversion QPSK demodulator. *IEEE Microwave and Wireless Components Letters* 18, 365–367.
13. Weng S, Shen C and Chang H (2012) A wide modulation bandwidth bidirectional CMOS IQ modulator/demodulator for microwave and millimeter-wave gigabit applications. *2012 7th European Microwave Integrated Circuit Conference*, Amsterdam, 2012, pp. 8–11.

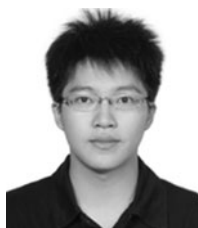


**Tian-Wei Huang** (Fellow, IEEE) received the Ph.D. degree in electrical engineering from the University of California at Los Angeles, Los Angeles, CA, USA, in 1993. He joined TRW Inc. (Northrop Grumman), Redondo Beach, CA, USA, where he designed millimeter-wave (MMW) / sub-THz radio frequency integrated circuit (RFIC). From 1998 to 2002, he was with Lucent Technologies, Murray Hill, NJ, USA, and Cisco Systems, San Jose, CA, USA, where he

developed high-speed wireless systems. In 2002, he joined National Taiwan University, Taipei, Taiwan, as a Faculty Member. His current research interests include MMW RF-CMOS design and gigabit wireless systems. Dr. Huang was a recipient of the IEEE Transactions on Advanced Packaging Best Paper Award in 2009. He was the Distinguished Microwave Lecturer of the IEEE MTT-S from 2015 to 2017. He was an associate editor of the IEEE Transactions on Microwave Theory and Techniques from 2015 to 2016.



**Yi-Cheng Huang** was born in Taichung, Taiwan, in 1999. He received the B.S. degree in electrical engineering from National Taiwan University, Taipei, Taiwan, in 2021. He is currently pursuing the Ph.D. degree of the Graduate Institute of Communication Engineering, National Taiwan University, Taipei, Taiwan. His research interests include RF and millimeter-wave (MMW) integrated circuits for wireless communications.



**Chen Chien** is an engineer with the Institute of Astronomy and Astrophysics, Academia Sinica, Taipei, Taiwan. His research interests include microwave engineering, RF and millimeter-wave (MMW) integrated circuits for wireless communications.



**Kun-Chan Chiang** received the B.S. degree in electrical engineering from National Taiwan Normal University, Taipei, Taiwan. He also received the M.S. degree from the Graduate Institute of Communication Engineering, National Taiwan University, Taipei, Taiwan. He is currently with Mediatek Inc., Taiwan. His research interests include CMOS integrated circuits, MMIC phase shifters, millimeter wave power amplifiers.



**Jeng-Han Tsai** (Member, IEEE) was born in Tainan, Taiwan, in 1980. He received the B.S. degree in electrical engineering from National Central University, Taoyuan, Taiwan, in 2002, and the Ph.D. degree from the Graduate Institute of Communication Engineering, National Taiwan University, Taipei, Taiwan, in January 2007. From February 2007 to January 2008, he was a post-doctoral research fellow with the Graduate Institute of Communication Engineering, National Taiwan University, where his research concerned advanced millimeter-wave (MMW) integrated circuits. From February 2008 to July 2009, he was an assistant professor with the Department of Communication Engineering, Yuan Ze University, Taoyuan. In August 2009, he joined the Faculty of the Department of Electrical Engineering, National Taiwan Normal University, Taipei, where he is currently a professor. His research interests include the design and analysis of RF, microwave, and MMW integrated circuits and systems. Dr. Tsai was a recipient of the IEEE Microwave Theory and Techniques Society (MTT-S) MWCL “Tatsuo Itoh” Award in 2021.